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## Comprehensive impedance spectroscopy, Raman, and infrared studies of the ferroelectric properties and application of BiFeWO<sub>6</sub>

B. S. Tripathy,<sup>a</sup> Balaji Umapathi, Priyabrata Nayak<sup>bc</sup> and S. K. Parida <sup>\*,a</sup>

Tetragonal double perovskite BiFeWO<sub>6</sub> nanopowders were successfully synthesized via the solid-state reaction technique. Structural characterization using X-ray diffraction (XRD) revealed an average crystallite size of 11.6 nm with a lattice strain of 0.06499. The study of the microstructure of the sample reveals uniform distribution of well-grown grains and presence of all constituent elements in both weight and atomic percentages. Optical properties were investigated through ultraviolet (UV)-visible spectroscopy, which revealed a bandgap energy of 1.41 eV, highlighting its potential for photovoltaic applications. Raman spectroscopy confirmed the presence of all constituent elemental vibrational modes associated with various molecular bonding interactions in the studied material. Dielectric analysis exhibited a Maxwell–Wagner-type polarization effect, indicating its potential as a material with a high dielectric constant and low loss for energy storage devices. The study of impedance plots revealed a negative temperature coefficient of resistance (NTCR) behavior, whereas the electrical modulus study suggested the presence of a non-Debye-type relaxation mechanism. The study of AC conductivity versus frequency and temperature revealed the fact that the conduction mechanism is controlled by thermally activated charge carriers. Again, semicircular Nyquist and Cole–Cole plots confirmed the semiconductor nature and well-supported impedance results. The resistance versus temperature plot showed an NTC thermistor character, indicating that BiFeWO<sub>6</sub> is a strong candidate for temperature sensor devices.

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## 1. Introduction

The realization of multiferroic material systems has united scientists across the globe with a common interest in exploring the phenomena associated with it. The term multiferroic was coined by H. Schmid to define a material system having two or more primary ferroic properties (ferroelectricity, ferromagnetism, ferroelasticity, and pyroelectricity) in a single phase.<sup>1,2</sup> The term magnetoelectric is a sub-group of multiferroic systems that includes materials in which electric polarization can be controlled by varying magnetic fields and *vice versa*. These materials are characterized by electromagnetic coupling. However, the definition included all the coupling mechanisms associated with charge and spin degrees of freedom.<sup>3,4</sup> Around the 1950s, when ferroelectricity and anti-ferromagnetism were very new physical phenomena, the Soviet Union was the first to try to

combine ferroelectric order and magnetic order. Smolenski and Ioffe created magnetic long-range order while retaining the ferroelectric state in single crystals like Pb(Fe<sub>0.5</sub>Nb<sub>0.5</sub>)O<sub>3</sub> and a polycrystalline solid solution like (1-x)Pb(Fe<sub>0.66</sub>W<sub>0.33</sub>)O<sub>3-x</sub>-Pb(Mg<sub>0.5</sub>W<sub>0.5</sub>)O<sub>3</sub>. By the 1960s, only 50 multiferroic systems were known, but none of them exhibited properties that were suitable for technological advancement.<sup>5</sup> In 1983, Baryakhtar *et al.* reported a model that elaborated on how magnetic order induces spontaneous electric polarization by breaking inversion symmetry. In 2000, Spaldin analyzed Ioffe's and Smolenski's work to explain the challenges in coexistence of ferroelectricity and ferromagnetism in a perovskite. This helped scientists to understand the reason why attempts to devise a novel multiferroic failed and encouraged them to take the challenge to find new way to resolve the issue related to concurrence of ferroelectric and ferromagnetic. In this way, a new era of multiferroics began.<sup>6</sup>

Perovskites are multiferroic materials with the structural formula ABX<sub>3</sub>, where A is a rare-earth or alkaline cation, B is a transition metal and X symbolizes a halide atom. BX<sub>3</sub> constitutes corner octahedra similar to ReO<sub>3</sub>, and A occupies the body center position with coordination number 12. Perovskite oxides

<sup>a</sup> Department of Physics, ITER, Siksha O Anusandhan Deemed to be University, Bhubaneswar, India. E-mail: santoshparida@soa.ac.in

<sup>b</sup> Pyrometallurgy & Materials Engineering Department, CSIR-IMMT, Bhubaneswar, India

<sup>c</sup> Academy of Scientific and Innovative Research, Ghaziabad, India



have different kinds of electronic properties.  $\text{BaTiO}_3$  is ferroelectric,  $\text{SrRuO}_3$  is ferromagnetic,  $\text{LaFeO}_3$  is weakly ferromagnetic, and  $\text{BaPb}_{1-x}\text{Bi}_x\text{O}_3$  shows superconducting behavior. By contrast,  $\text{LaCoO}_3$  shows the insulator-metal transition at the same time that many perovskites have metallic conductivity, *e.g.*,  $\text{ReO}_3$ ,  $\text{A}_x\text{WO}_3$ ,  $\text{LaTiO}_3$ ,  $\text{SrVO}_3$  &  $\text{LaNiO}_3$ . Interestingly, the strong cation-anion-cation interaction is the cause of metallic conductivity in the ceramic compounds. To enhance the properties in the single perovskite, the doubling of the unit cell to create a material called the double perovskite was introduced.

These materials are invented by doping suitable elements at A and B sites, having general structural formula  $\text{A}'\text{A}''\text{B}'\text{B}''\text{O}_6$  or  $\text{A}_2\text{B}'\text{B}''\text{O}_6$ . Suitable elements for B site doping include the 3d/4d/5d transition metals and the lanthanide series with small ionic radii. These elements comprise the largest proportion in the periodic table, thus providing a wide range of choices for scientists to tailor the material properties for potential applications. A site can also host two different cations as in  $\text{A}'\text{A}''\text{B}'\text{B}''\text{O}_6$ , which is named as the double-double perovskite. Double perovskites are suitable candidates for replacing single perovskites to attain better performance and stability. Specifically, they have a greater space to accommodate additional atoms; hence, increasing the compositional space of the perovskite family. Another advantage is the complex atomic environment that is created by double perovskites, resulting in electronic structures that are absent in single perovskites. These perovskites are chemically stable under catalytic conditions that include a wide range of oxidizing and reducing agents, acidic or basic solutions, humidity, heat, light, and  $\text{CO}_2$  environments. However, the lead toxicity raises a major concern about the commercialization and large-scale application of halide perovskites. Exposure to a small quantity can cause severe damage to the nervous system and renal system, as well as impaired bone calcification. Lead halides having high solubility product constant ( $K_{\text{SP}}$ ) values are easily soluble in water, causing damage to ecosystems in the environment. Therefore, scientists are currently searching for good alternatives to replace lead for the manufacture of perovskites with low toxicity and high performance.<sup>7</sup> Ravi Shankar *et al.* found a long-range anti-ferromagnetic ordering and magnetoelectric coupling in  $\text{NaLnNiWO}_6$  ( $\text{Ln} = \text{Er, Tm, Lu}$ ).<sup>8</sup> Other materials include  $\text{Na}_3\text{AlF}_6$ , which is a very important material for aluminum processing, and  $\text{Sr}_2\text{FeMoO}_6$ , which is of greater importance due to its unusual electric and magnetic properties arising from the alternation between  $\text{Mo}^{\text{V}}$  and  $\text{Fe}^{\text{III}}$  ions.<sup>9</sup> L. Boudad *et al.* reported on the cubic double perovskites  $\text{EuBaFeTiO}_6$  and  $\text{LaBaFeTiO}_6$  with large band gap values of 3.53 eV and 3.75 eV, respectively.<sup>10</sup> Rutuparna Das *et al.* reported on the anti-ferromagnetic ordering in  $\text{Y}_2\text{CoMnO}_6$ .<sup>11</sup> Liangdong Chen *et al.* reported on the application of the double perovskite as oxygen evolution reaction electrocatalysts and supercapacitors.<sup>12</sup>

Ferrite ferromagnetic oxides are known to have high resistivity, as well as high permeability. Although ferromagnetic alloys have more than double the value of saturation polarization compared to ferrites, ferrites have advantages in terms of

their applicability at higher frequency, higher resistivity, low cost, high heat, and corrosion resistance.<sup>13–15</sup> There is a growing interest in the synthesis of ferrites because of their chemical stability, biological compatibility, relative ease of preparation, and numerous applications associated with ferrites, including mechanical applications,<sup>16</sup> magnetic data storage, microwave absorbers,<sup>17–19</sup> sealants, lubricants, and coolants.<sup>20,21</sup> The main reason for the increased applicability of ferrites is the ease of detection and manipulation of the application of an external magnetic field. Lithium ferrite, due to its high Curie temperature ( $T_c$ ) and high saturation magnetization ( $M_s$ ), low magnetic losses, high chemical stability, and high resistivity, is a magnetic material with high technological and scientific interests.<sup>22–24</sup>

Bismuth ferrite (BFO) is a multiferroic material that exhibits both ferromagnetic and ferroelectric properties. It is also known for its high transition temperatures ( $T_c \sim 1100$  K,  $T_N \sim 653$  K). Experimental results on BFO were first reported in 1957.<sup>24–26</sup> Later, its room-temperature ferroelectric property with remnant polarization ( $P_r$ ) was reported to be more than 50  $\text{mC cm}^{-2}$  in 1970. Interestingly, research interest in BFO surged in 2003 when Ramesh *et al.* reported on an exceptional increase in the remanent polarization ( $P_r$ ), reaching 60  $\mu\text{C cm}^{-2}$ , approximately 15 times higher than that previously recorded in bulk BFO samples. This breakthrough has since driven further advancements in the material's structural and electronic properties, solidifying its potential in next-generation magnetoelectric devices.<sup>26–28</sup> In recent times, numerous  $\text{BiFeO}_3$ -based multiferroics have been developed by doping suitable elements at either the A-site or B-site or both, which has led to a better understanding of the underlying magnetic and electric mechanisms. These  $\text{BiFeO}_3$ -based multiferroics are thus a promising candidate for applications in next-generation storage, information, and spintronics. In traditional ferroelectric materials, the transition metals are characterized by an empty d-shell, known as a  $d^0$  configuration. However, the BFO ceramic is different as it does not have any transition metal with an empty d-shell. Instead, it contains  $\text{Fe}^{3+}$  ions with a  $d^5$  configuration. Interestingly, the ferroelectricity in BFO is not due to these transition metal ions. It is caused by the  $\text{Bi}^{3+}$  ions (A site cation). An active lone pair of electrons in the valence state in  $\text{Bi}^{3+}$  ions in the  $\text{sp}^2$  hybridized states take part in chemical bonding. The presence of the ( $s^2$ ) lone pair electrons in the Bi ions leads to a disruption of the local inversion symmetry in BFO. Consequently, the small B-site cation, Fe, minimizes its energy by shifting along the [111] crystallographic directions, influencing the material's structural and electronic properties. This is a unique characteristic of BFO that sets it apart from conventional ferroelectric materials.<sup>29</sup>

Tungsten trioxide ( $\text{WO}_3$ ) is indeed a fascinating compound, where its structure is temperature-dependent. It is tetragonal at temperatures above 740 °C, orthorhombic from 330 to 740 °C, monoclinic from 17 to 330 °C, triclinic from –50 to 17 °C, and monoclinic again at temperatures below –50 °C. The most common structure of  $\text{WO}_3$  is monoclinic with the space group  $P21/n$ . The pure compound is an electric insulator, but oxygen-deficient varieties, such as  $\text{WO}_{2.90} = \text{W}_{20}\text{O}_{58}$ , are dark blue to



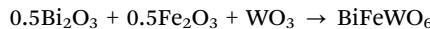
purple and conduct electricity. These can be prepared by combining the trioxide and the dioxide  $\text{WO}_2$  at 1000 °C in a vacuum. Tungsten trioxide is a transition metal oxide known for its n-type semiconductor properties, exhibiting a bandgap ranging from 2.6 to 3.0 eV. This material has garnered significant interest due to its high coloration efficiency, remarkable chemical stability, rapid switching kinetics, and excellent electrochemical activity. These characteristics make  $\text{WO}_3$  a promising candidate for applications in electrochromic devices, gas sensors, and energy storage systems.<sup>30</sup>

Lastly,  $\text{WO}_3$  exhibits fascinating characteristics such as structural and ferroelectric properties, among others. The manifestation of these properties is influenced by the synthesis method employed and the specific conditions under which the experiments are conducted. Notably,  $\text{WO}_3$  displays ferroelectric properties at low temperatures (below 230 K).<sup>31</sup> Consequently, it is anticipated that incorporating a minor quantity of this compound into BFO could lead to intriguing multiferroic properties, including a transition temperature shift. A similar type of work on modified  $\text{BiFeWO}_6$  has already been reported in the literature.<sup>32–35</sup> Interestingly, in this context, the preliminary structural analysis, microstructure, dielectric, electrical, Raman, infrared, and ferroelectric properties of  $\text{BiFeWO}_6$  ceramics with potential applications have not explored in a single investigation. Therefore, the authors have decided to synthesize the same  $\text{BiFeWO}_6$  ceramic in the solid-state reaction method and investigate all of the mentioned physical properties in one frame, searching for possible applications in the field of science and technology. Finally, a comprehensive study on lead-free compound  $\text{BiFeWO}_6$  is discussed extensively in the next section.

## 2. Experimental details

### 2.1. Raw materials

A cost-effective standard fabrication technique, the high-temperature sintering method, was employed to synthesize the single-phase polycrystalline double perovskite  $\text{BiFeWO}_6$ . Analytical reagent (AR) grade raw materials, including  $\text{Bi}_2\text{O}_3$  (Bismuth oxide),  $\text{WO}_3$  (Tungsten oxide), and  $\text{Fe}_{20}\text{O}_3$  (Iron(III) oxide), were sourced from M/S Hi-Media Lab with a purity of  $\geq 99\%$ . The raw materials were precisely weighed in stoichiometric ratios using an electronic balance [New Classic MF: MODEL-ML204/A01], ensuring an accuracy of up to four decimal places. The sample preparation followed the chemical equation detailed below.



### 2.2. Synthesis and sintering

The weighed samples were thoroughly mixed through dry grinding using an agate mortar and pestle for 4 h for uniform mixing and reduction of the powder sample into the nanoscale. The prepared mixture was subjected to calcination in a high-purity alumina crucible for six hours using a high-temperature muffle furnace at 850 °C to ensure phase stability. The formation

of a stable sample was verified through X-ray diffraction (XRD) analysis using a Rigaku Japan Ultima IV diffractometer ( $\text{Cu K}\alpha$ ,  $\lambda = 1.540510 \text{ \AA}$ ). The diffraction patterns were recorded over a broad range of Bragg angles ( $20^\circ \leq \theta \leq 80^\circ$ ) at a scanning speed of  $0.2^\circ \text{ min}^{-1}$  to confirm crystallinity and phase purity. Polyvinyl alcohol was added to the calcined powder in 1 wt% to make cylindrical pellets using a KBr hydraulic press under a pressure of  $4 \times 10^6 \text{ N m}^{-2}$  of 1–2 mm thickness and 10–12 mm diameter. The pellet undergoes sintering at 800 °C for three hours to enhance its compactness and density, ensuring improved structural integrity and material stability.

### 2.3. Characterization

The structural characterization was carried out using an X-ray diffractometer (Rigaku Japan Ultima IV,  $\text{Cu K}\alpha$ ,  $\lambda = 1.540510 \text{ \AA}$ ) to determine the crystallinity and phase purity. Microstructural analysis was conducted using scanning electron microscopy (SEM), with data obtained through an SEM-EDX system (Model Zeiss EVO 18) to examine the surface morphology and elemental composition. The optical properties of the synthesized sample were evaluated using a UV spectrometer (CECIL CE3055, 3000 series), providing insights into its absorption and bandgap characteristics. Additionally, the dielectric properties were investigated using an impedance analyzer, enabling the assessment of its electrical behavior and potential applications in electronic devices. Micro-Raman spectroscopy [lab Ram HR800, Jobin Yvon, wavelength = 488 nm] was tailored to record the characteristic vibrational modes of the prepared sample. High-temperature dielectric data were recorded from the LCR analyzer MODEL: N4L PSM, 1735 provided with a frequency range of 1 kHz–1 MHz and temperature range of 25–500 °C. The ferroelectric nature of the prepared sample was tested by the polarization *versus* electric field ( $P$ – $E$ ) loop tracer (M/S Marine, India), and different possibilities for the device applications were explored.

## 3. Results and discussions

### 3.1. Sample formation

Goldschmidt's tolerance factor, introduced in 1926, plays a crucial role in predicting the formation, crystal symmetry, and structural stability of the material BMFW. It provides a mathematical framework for assessing the ionic radii compatibility of the constituent elements, ensuring optimal lattice stability and phase formation. This factor can be expressed as:

$$t = \frac{r_{(\text{A}+\text{A}')} + r_{(\text{O})}}{\sqrt{2}(r_{(\text{B}+\text{B}')/2} + r_{(\text{O})})}$$

where  $\text{RA}$ ,  $r_{\text{A}'}$ ,  $r_{\text{B}}$ ,  $r_{\text{B}'}$ , and  $r_{\text{O}}$  represent the ionic radii of the A-site cation, A'-site cation, B-site cation, B'-site cation, and the oxygen anion, respectively. The tolerance factor of the studied material has been calculated as 0.96, suggesting a tetragonal structural symmetry.<sup>36</sup>



### 3.2. XRD analysis

X-ray diffraction (XRD) is a crucial analytical technique for examining the crystalline structure of ceramic materials. By analyzing the angles and intensities of diffracted X-rays, XRD provides essential information about the crystal lattice, phase composition, and crystallite size of ceramics.

Fig. 1(a) show the X-ray diffraction pattern of the BiFeWO<sub>6</sub> ceramic at room temperature. The structural analysis was done using X-Pert High-Score software and a tetragonal structure was obtained for BiFeWO<sub>6</sub> (JCPDS: 00-038-1289). The structural lattice parameters are as follows:  $a = b = 12.4400 \text{ \AA}$ ,  $c = 3.6400 \text{ \AA}$  and  $\alpha = \beta = \gamma = 90^\circ$ . The average crystallite size ( $D$ ) and lattice strain ( $\varepsilon$ ) were determined using Williamson–Hall (W–H) plot, as shown in Fig. 1(b). The mathematical relation of the W–H method can be written as  $\beta \cos \theta = 4\varepsilon \sin \theta + \frac{k\lambda}{D}$ , where  $\beta$  represents the full width at half-maximum (FWHM) of the reflection,  $\theta$  is the Bragg angle,  $\lambda$  denotes the X-ray wavelength ( $\sim 0.154 \text{ nm}$ ), and  $k$  is a dimensionless shape factor, typically assigned a value of  $\sim 0.89$ . The calculated average crystallite size was found to be 11.69 nm, with dislocation density  $\sigma = \frac{1}{D^2} = 7.3 \times 10^{-3} \text{ nm}^{-2}$  and lattice micro-strain of 0.06499.

### 3.3. Microstructural analysis

Scanning electron microscopy (SEM) utilizes probing beams that are narrower at both low and high electron energy, enhancing spatial resolution while reducing sample damage. It enables the identification of contamination spots in small areas at electron-accelerating voltages and is compatible with energy-dispersive X-ray spectroscopy. It also allows the application of low kinetic energy electrons closer to the immediate material surface and eliminates the need for conducting coatings on insulating materials.<sup>37</sup> Fig. 2(a) shows the SEM micrograph of the studied sample. The figure shows the presence of irregularly shaped grains with non-uniform size, showing that the polycrystalline sample is distorted. However, the grains are

distributed uniformly with well-defined grain boundaries, which can be seen from the figure. The high density of the formed sample is confirmed by the closely packed grains leaving negligible voids.

Fig. 2(b) displays the grain distribution curve, with the grain size (in  $\mu\text{m}$ ) on the  $x$ -axis and the number of particles on the  $y$ -axis. ImageJ software was utilized to determine the number of particles and their corresponding grain sizes. The average grain size, determined by fitting the histogram data, was found to be  $0.818 \mu\text{m}$ . Grains are highly compact and provide well-defined grain boundaries. The agglomeration ratio, *i.e.*, ratio of the grain size to crystallite size, is found to be 70, which may be one of the reasons for the better electrical conduction process.<sup>38</sup> Fig. 2(c) shows the EDX spectrum of the BiFeWO<sub>6</sub> ceramic at room temperature. It is observed that all the constituents (Bi, Fe, W, O) are present in both weight and atomic percentages.

### 3.4. UV-Visible spectroscopy

UV-visible spectroscopy is often used to provide characterization data for various materials including both organic and inorganic chemical substances. When an electronic transition is induced in a molecule or ion due to the radiation, the material exhibits absorption in the visible or ultra-violet (UV) region. As a result, a change in electronic structure occurs in the material due to the absorption of light in the visible or UV region. Functional groups in inorganic or organic, solid, or liquid materials can be observed using UV-visible spectroscopy. Depending on the degree of transmittance or absorbance of radiation and sample behavior, UV-visible spectroscopy provides details regarding the bandgap measurements.<sup>39</sup>

Fig. 3(a) [inset] shows the absorbance spectrum in the wavelength range of 200–1100 nm. The sample shows an absorbance peak at 305 nm which is in the UV range; however, the sample absorbs all the visible radiations. Bi-based oxide materials can make use of valence bands O 2p and Bi 6s, have a low bandgap, and absorb more visible radiation.<sup>15,16,40</sup>

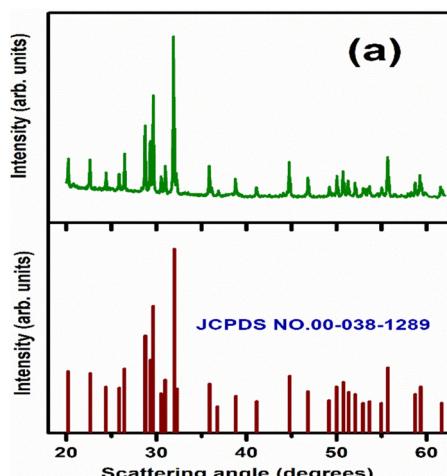
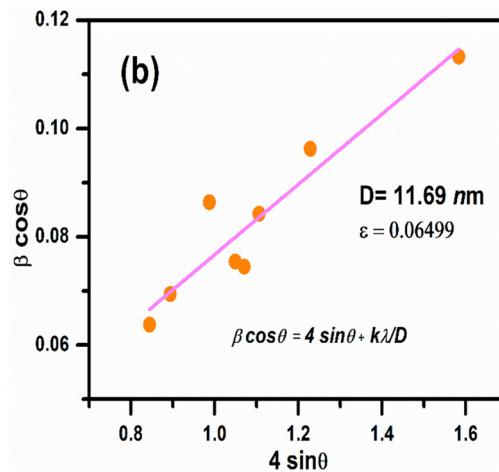


Fig. 1 (a) XRD pattern and (b) W–H plots of the BFWO ceramic.



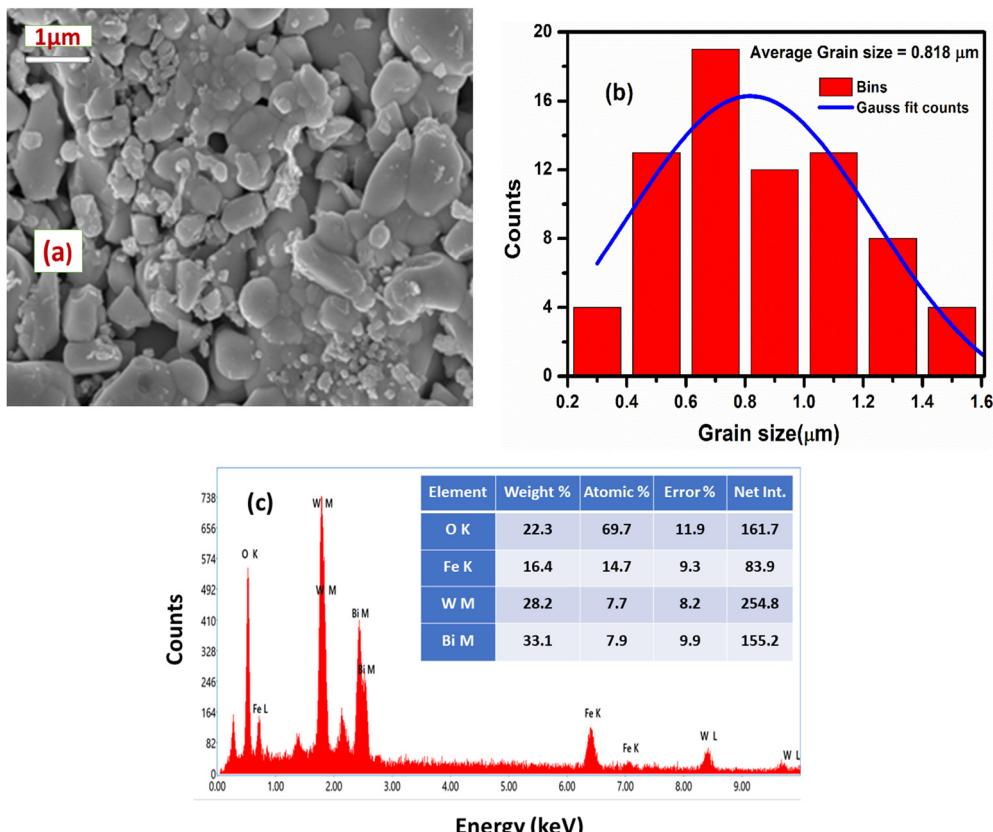


Fig. 2 (a) SEM micrograph, (b) Gaussian fitting grain size using ImageJ software, and (c) EDX spectrum confirming the presence of all constituent elements.

The bandgaps in semiconducting materials can be either a directly allowed, indirectly allowed, directly forbidden, or indirectly forbidden transition depending on the type of material.

In the case of a directly (vertical) allowed transition, the energy-dependent absorption coefficient  $\alpha(E)$  follows:

$$\alpha_{\text{dir}}(E < E_g) = 0$$

and

$$\alpha_{\text{dir}}(E \geq E_g) \propto (E - E_g)^{1/2}$$

where  $\alpha_{\text{dir}}$  is the direct optical absorption coefficient,  $E$  =  $h\nu$  (photon energy), and  $E_g$  is the band gap energy. Such behavior is expected for transitions with negligible changes in the electron wave vector  $k$  with factors regarding the atomic bonding and selection rules. In such a case, the  $E_g$  value can be calculated by extrapolating the linear least squares fit  $\alpha^2$  to 0 in the “ $\alpha^2$  versus  $E_g$  plot”. In contrast, the indirect transition or non-vertical optical transition involves a photon and at least one phonon to satisfy a conservation of momentum. The transition rate taking place in the case of indirect optical band gap semiconductors is smaller than that in the case of direct band gap semiconductors. The corresponding  $\alpha(E)$  follows the relation:

$$\alpha_{\text{dir}}(E < E_g) = 0$$

and

$$\alpha_{\text{dir}}(E \geq E_g) \propto (E \pm h\nu - E_g)^{1/2},$$

where  $h\nu$  represents the energy of the phonon,  $+h\nu$  represents the energy of the emitted phonon, and  $-h\nu$  is the energy of the absorbed phonon. In most cases, the contribution of  $h\nu$  can be neglected.

The indirect  $E_g$  can be calculated by extrapolating the linear least squares fit of  $\alpha^{1/2}$  to zero “ $\alpha^{1/2}$  versus  $E$ ” plot, as shown in Fig. 3(b). The optical bandgap of the  $\text{BiFeWO}_6$  sample is calculated following Tauc's mathematical formulation;  $\alpha h\nu = A(h\nu - E_g)^\gamma$ , where  $A$  denotes the characteristic parameter, and  $n$  represents the exponential term.<sup>41</sup> The parameter  $\gamma$  takes values of 1/2, 2, 3/2, and 3, corresponding to directly allowed, indirectly allowed, directly forbidden, and indirectly forbidden band transitions, respectively.<sup>42</sup> The value of the indirect bandgap energy  $E_g = 1.41$  eV in the sample is calculated by extrapolating the linear portion of the plot onto the  $X$ -axis, corresponding to energy with  $(\alpha h\nu)^{1/2} = 0$ . The calculated bandgap value for  $\text{BiFeWO}_6$  is lower than those from earlier reported articles (2.24 eV,<sup>43</sup> 1.70 eV,<sup>44</sup> 1.65<sup>45</sup>).

The decrease in the bandgap value is due to the oxygen vacancies, which results in positive structural defects. Such sites can capture one or two electrons and act as donor centres.

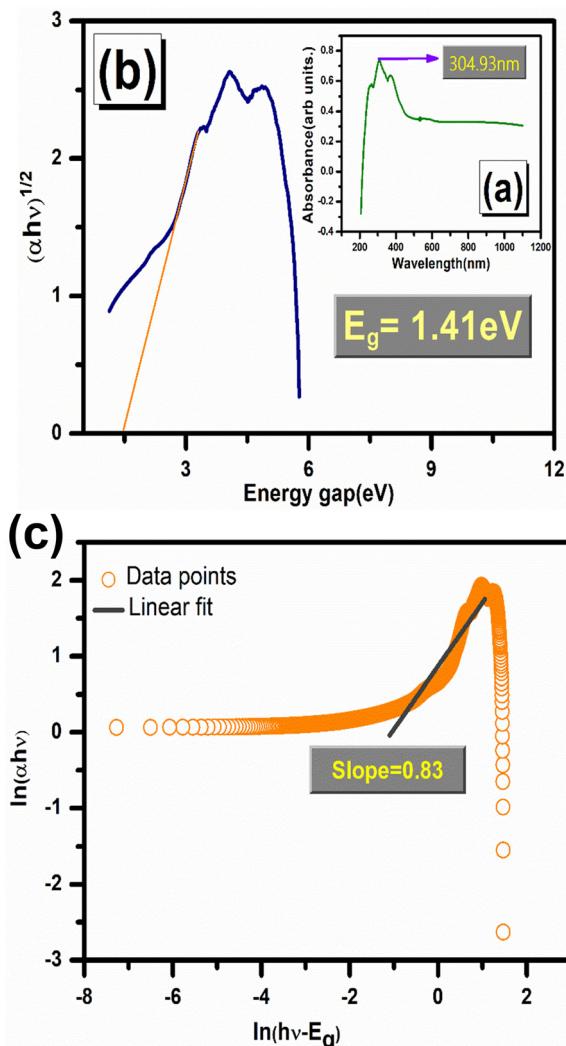


Fig. 3 (a) Absorbance spectrum [inset] and (b) Tauc plot of  $\text{BiFeWO}_6$ . (c) Calculation of the  $n$  value from  $\ln(\alpha h\nu)$  versus  $\ln(h\nu - E_g)$  of  $\text{BiFeWO}_6$ .

These donor centre levels are located close to the valence band.<sup>38</sup> Tauc's formulation can also be written as:  $\ln(\alpha h\nu) = \ln A + \gamma \ln(h\nu - E_g)$ . The value of  $n$  is determined from the slope of the plot of  $\ln(\alpha h\nu)$  versus  $\ln(h\nu - E_g)$ . The calculated slope of 0.83 deviates from the expected value of 0.5, which corresponds to a direct bandgap transition. This deviation confirms that the sample exhibits an indirect electronic transition.<sup>46</sup>

The refractive index ( $n$ ) is an important optical constant that depends on the wavelength of electromagnetic radiation through dispersion, and helps in understanding the optical device application potentiality of any prepared material.<sup>47</sup> The band gap decreases with an increase in the refractive index in a semiconducting material, which tells us that these two quantities must be related. S. K. Tripathy *et al.* proposed a relation between the refractive index and energy band gap,  $n = n_0(1 + \alpha e^{-\beta E})$ , where  $n_0$ ,  $\alpha$  and  $\beta$  are the constants with values of 1.73, 1.9017 and  $0.539(\text{eV})^{-1}$ , respectively. Using this formulation, the value of the refractive index for the sample was found to be 3.27.<sup>48</sup> The refractive index value can be calculated by a

model proposed by Kumar and Singh as it includes many different materials, including semiconductors materials, halides, and insulators. As per the model, the value of the refractive index can be calculated using  $n = KE_g^C$ , where  $K = 3.3668$  and  $C = -0.32234$  are constants.<sup>24,25</sup> So, from the mathematical formulation, the  $\eta$  value was found to be 3.014. The electron polarizability ( $\alpha'$ ) can be calculated by using the formula,  $\alpha' = \left[ \frac{12.41 - 3\sqrt{E_g - 0.365}}{12.41} \right] \frac{M}{\rho} \times 0.395 \times 10^{-24} \text{ cm}^3$ ,

where  $M$  is the molecular weight (in  $\text{g mol}^{-1}$ ) and  $\rho$  is the density of the material (in  $\text{g cm}^{-3}$ ).<sup>49</sup> Following the formulation, the value of the electron polarizability ( $\alpha'$ ) is found to be  $24.84 \times 10^{-24} \text{ cm}^3$ .  $\chi^3$  is the third-order non-linear optical susceptibility and provides detailed information about the strength of chemical bonds between molecules in the synthesized nanocrystalline materials. This quantity can be calculated from the first-order susceptibility ( $\chi^1$ ) of ceramics by using

$$\chi^1 = \frac{n^2 - 1}{4\pi} \text{ and } \chi^3 = A[\chi^1]^4, \text{ where the value of } A = 1.7 \times 10^{-10} \text{ esu.}$$

Using the above formulae, the values of the first-order and third-order susceptibility was found to be 0.77 and  $6.03 \times 10^{-11}$  esu, respectively.<sup>27,28</sup> Another important parameter is the carrier concentration ( $n_c$ ) in the field of photovoltaics, as it influences the doping and the oxidation states of the crystals.<sup>50</sup> The relation between the calculated bandgap ( $E_g$ ) and carrier concentration ( $n_c$ ) can be stated

$$\text{as } n_c = \left[ \frac{E_g}{2.7924462} \times 10^{37} \right]^{3/2}, \text{ which gives the value of } n_c \text{ as}$$

$1.14 \times 10^{55}$ . This makes the material a suitable and potential candidate for optoelectronic applications. We have also calculated the high-frequency dielectric constant ( $\epsilon_\infty$ ) and static dielectric constant ( $\epsilon_0$ ) using the following mathematical formulation:  $\epsilon_\infty = n^2$  and  $\epsilon_\infty = 11.26 - 1.42E_g$  and  $\epsilon_\infty = 18.52 - 3.08E_g$ .<sup>52</sup> The values of the high-frequency dielectric constant were calculated to be 10.69 (from the refractive index) and 9.2578 (from the energy band gap), and the static dielectric constant value for the prepared sample was found to be 14.177. The oscillator strength value was found to be 2.82 eV for the prepared sample, calculated using the following relation: oscillator strength =  $2E_g$ .<sup>49,53</sup> The results of different parameters tell us the potentiality of the sample for application in optoelectronic devices. The absorption peak occurs at the UV region of the radiation, which indicates the material's UV sensing application.

### 3.5. Raman study

Raman spectroscopy is a powerful analytical technique used to study the vibrational, rotational, and other low-frequency modes in molecules. It is based on the inelastic scattering of light, where incident photons interact with molecular vibrations, leading to a shift in their energy. This technique is widely used in material science, chemistry, biology, and nanotechnology for identifying molecular compositions and structural changes. Raman spectroscopy is highly sensitive to molecular fingerprints, making it essential for non-destructive chemical analysis. It plays a crucial role in studying crystal structures, phase transitions, and even biomedical diagnostics. Its ability to analyze substances without extensive sample



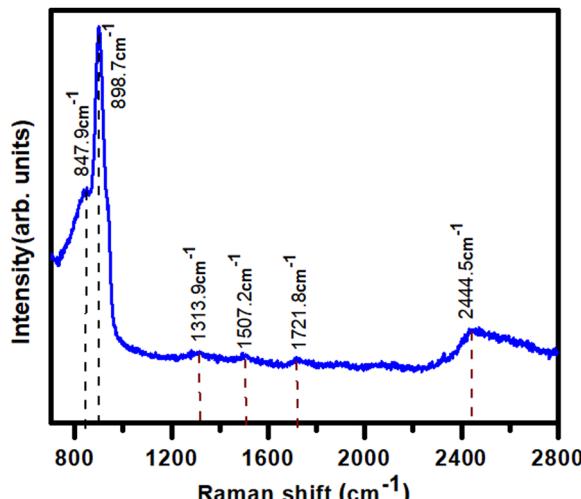


Fig. 4 Raman spectrum of BiFeWO<sub>6</sub>.

preparation makes it invaluable in scientific and industrial applications.

Fig. 4 shows the Raman spectrum of the BiFeWO<sub>6</sub> ceramic at room temperature. The spectrum reveals distinct peaks at 847.9 cm<sup>-1</sup>, 898.756 cm<sup>-1</sup>, 1313.997 cm<sup>-1</sup>, 1507.154 cm<sup>-1</sup>,

1721.773 cm<sup>-1</sup>, and 2444.479 cm<sup>-1</sup>. These spectral features were compared with the existing literature to determine their molecular origins. A study of the Raman spectra from previously published works suggests that the 847.9 cm<sup>-1</sup> & 898.756 cm<sup>-1</sup> peaks correspond to the Fe–O or W–O stretching vibrations,<sup>54</sup> indicating the interaction between iron & tungsten with oxygen; the 1313.997 cm<sup>-1</sup> & 1507.154 cm<sup>-1</sup> peaks are likely associated with Bi–O or Fe–O bond interactions<sup>55</sup>; and the 1721.773 cm<sup>-1</sup> & 2444.479 cm<sup>-1</sup> peaks may be linked to higher-order phonon modes or lattice strain.<sup>56</sup>

### 3.6. Dielectric study

Fig. 5(a and b) illustrates the variation of the dielectric constant ( $\epsilon_r$ ) and dielectric loss ( $\tan \delta$ ) as a function of frequency in the range of 1 kHz to 1 MHz and temperature range of 25 °C to 500 °C. From Fig. 5(a), we can see that the dielectric values in the low-frequency region are very high in magnitude and dispersed, and increase with the temperature rise. However, the value of the dielectric constant decreases with the rise in frequency of the applied external electric field, and assumes a minimum value at 1 MHz even at very high temperatures. The dielectric constant value is determined by the ability of the dipolar orientation w.r.t. the applied external field. The types of polarization occurring are classified into four types: electronic,

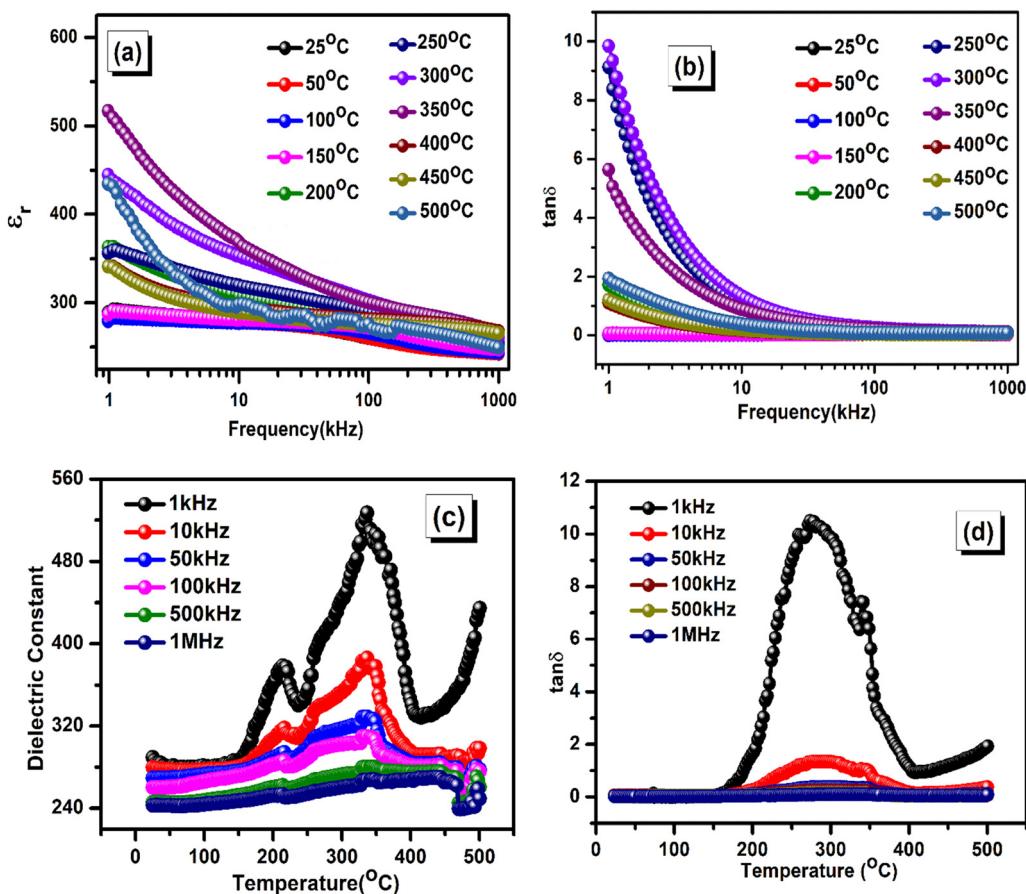


Fig. 5 (a) and (b) Variation of the dielectric constant and tangent loss versus frequency. (c) and (d) Variation of the dielectric constant and tangent loss versus temperature of BiFeWO<sub>6</sub>.

atomic, dipolar, and interfacial. Space charges are the polarizable units for interfacial polarization. With a field frequency below 1 kHz, the interfacial polarization persists. This is the reason for the high dielectric constant value in lower-frequency regions. Around 1 kHz, dipolar polarization comes into the picture, which results in the lowering of the dielectric constant values at all studied temperatures, as depicted in the plot. Atomic/ionic polarization occurs at around 30–40 kHz, as the increase in magnitude pulls the center of the negatively charged electron cloud away from the nucleus. This further reduces the value of the dielectric constant. All other polarization ceases at a frequency higher than 100 kHz, resulting in electronic polarization dominating the polarization phenomenon. Thus, at higher frequencies, the dielectric constant contribution of the material is solely due to the electronic polarization, which can be understood from the merged plots for all temperatures. At low frequencies, the entire dielectric constant value is due to space polarization. As the frequency exceeds a certain value, dipoles lose their ability to align according to the applied field. The contributions of other polarization units decrease, leaving behind only electronic polarization. Thus, the dielectric constant values become invariant and the distinct plots merge at higher frequency regions.<sup>57–59</sup> The loss factor  $\tan \delta$  arises due to the phase difference resulting from energy loss during the polarization phenomena at various frequencies. The tangent loss appears in a material if the polarization cannot follow with the applied electric field. The difference in energy occurs because the total polarization lags behind the applied field. As shown in plot 5(b), the tangent loss value is high at lower frequency regions due to the higher values of the dielectric constant. As the frequency increases, the value lowers. The dielectric loss value becomes minimum and invariant as the loss at higher frequencies is only due to electronic polarization, following the same pattern as that for the dielectric constant. The above phenomena were explained by Maxwell–Wagner's two-layer model and Koop's theory.<sup>47</sup> While considering electrical conduction, electrons are more active at grain boundaries in low frequencies whereas at grains during high frequencies. The grain boundaries are characterized by high resistance; hence, there is more electrical energy loss to facilitate carrier motion when the frequency of the applied field is low. In contrast, grains offer relatively low resistance; as a result, energy loss is minimized as the applied field frequency increases. Debye's relaxation model also explains the decrease of the dielectric constant, as well as the loss value with an increase in the applied field frequency. Since conductivity is frequency-dependent, the accumulation of charge carriers at grain boundaries leads to interfacial or space-charge polarization.<sup>58</sup>

The variation plot of the dielectric constant and tangent loss in a temperature range of 25 °C to 500 °C at a frequency range of 1 kHz–1 MHz is depicted in Fig. 5(c and d). The dielectric constant increases with rising temperature, but decreases as the frequency increases. At lower temperatures, the dipoles lack sufficient energy to align with the applied electric field, resulting in a lower dielectric constant.<sup>59</sup> In Fig. 5(c), around the

reported Néel's temperature (~370 °C), an anomaly can be observed in the permittivity value.<sup>60</sup> The peaks of the dielectric constant value are due to the change in state of the electric dipole ordering, which is probably due to the presence of an anti-ferromagnetic transition or magnetoelectric effect in the sample.<sup>61</sup> The Landau–Devonshire theory of phase transition describes such an anomaly in magnetoelectric systems, which is an effect of vanishing magnetic order on electric order.<sup>62</sup> The plot corresponding to 1 kHz frequency shows the maximum value of the dielectric constant at around 350 °C. As the frequency increases, the  $\epsilon_{\max}$  value decreases due to the electron–phonon interactions.<sup>63</sup> Above 390 °C, the increase in the value of the dielectric constant can be attributed to the thermally activated transport process and the presence of space charges. The space charge contribution is the result of oxygen vacancies created during the sintering of sample pellets at high temperatures.<sup>64</sup> Due to the oxygen vacancies, the valency state of  $\text{Fe}^{3+}$  changes to  $\text{Fe}^{2+}$ . Besides the oxygen vacancies, the rise in  $\epsilon_r$  value also affects the electron hopping in the direction of the applied electric field between the  $\text{Fe}^{3+}$  and  $\text{Fe}^{2+}$  octahedral sites.<sup>65</sup> Above 390 °C, an increase in the value of  $\epsilon_r$  can be seen, which is due to the dipolar contribution of the  $\text{BiFeO}_3$  ferroelectric component. Fig. 5(d) shows the temperature dependence of  $\tan \delta$  in a frequency range of 1 kHz to 1 MHz. The plots follow a similar pattern as that of  $\epsilon_r$ . In low-temperature regions, the plots are merged into one. However, with an increase in temperature, the  $\tan \delta$  value increases rapidly following an increase in  $\epsilon_r$  values. For temperature values above 300 °C, the values decrease due to the scattering of thermally activated charge carriers and the oxygen point defects. For an ideal case, the material should possess high resistance and low dielectric loss. The vacancies generated during high-temperature sintering may lead to the release of single or double-ionized oxygen vacancies, accompanied by the liberation of one or two electrons, respectively. Dielectric relaxation is influenced by dipoles, while oxygen vacancies extend beyond a single unit cell, impacting the entire material and contributing to an increase in ionic conductivity.

### 3.7. Impedance study

Impedance spectroscopy is related to the permittivity and distinguishes between the conducting and non-conducting regions of the sample. At shorter time scales, electrical spectroscopy serves as an effective tool for analyzing both electronic and ionic conduction properties. The frequency-dependent permittivity spectrum can be measured from these relaxation times. Permittivity reduces the dielectric constant.<sup>66</sup>

Mathematical tools used in electrical impedance spectroscopy are as follows:

$$Z^* = Z' + jZ''$$

$$Z' = \frac{R}{1 + (\omega\tau)^2}$$

$$Z'' = \frac{-\omega R\tau}{1 + (\omega\tau)^2}$$



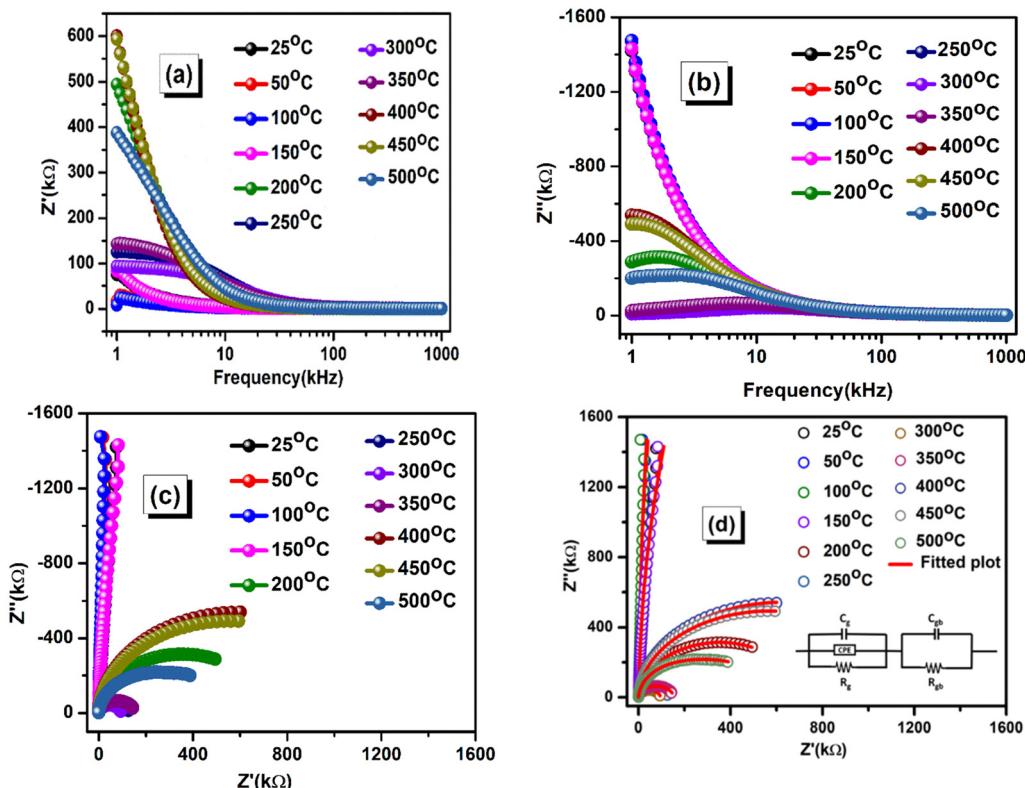


Fig. 6 (a)  $Z'$  versus frequency, (b)  $Z''$  vs. frequency and (c) Nyquist plots. (d) Fitted Nyquist plots of  $\text{BiFeWO}_6$ .

where  $Z^*$  represents the complex impedance, with  $Z'$  as its real part and  $Z''$  as its imaginary part;  $R$  denotes resistance and  $j$  is the imaginary unit  $\sqrt{-1}$ , while  $\omega$  and  $\tau$  correspond to the angular frequency and relaxation time, respectively.<sup>67</sup> Fig. 6(a and b) shows the frequency dependence plots of the  $Z'$  and  $Z''$  complex impedances at selected temperatures. As can be seen from the plot, the values of both  $Z'$  and  $Z''$  decrease with the increase in frequency and temperature. The  $Z'$  plots at higher frequencies merge, owing to the release of space charges, resulting in a reduction of barrier properties in the sample at higher frequencies.<sup>67</sup>

The increase in conductivity observed in the sample with rising temperature and frequency is associated with a single relaxation phenomenon. This tells us about the negative temperature coefficient of the resistance behaviour of the sample. The negative temperature coefficient of resistance (NTCR) behaviour is a defining characteristic of semiconducting materials, indicating the dielectric nature of the sample.<sup>68</sup> The spectrum loss of  $Z''$  in Fig. 6(b) varies with frequency, as evidenced by the presence of a distinct peak. The shift of the relaxation process to higher frequency regions with increasing temperature indicates its temperature dependence. The asymmetrically broadened peaks observed over time suggest the presence of multiple relaxation mechanisms. At lower temperatures, the relaxation is primarily influenced by electrons and immobile ions. Conversely, at higher temperatures, oxygen vacancies and defects play a dominant role. The conductivity in the sample arises from electron hopping and oxygen

vacancies generated during high-temperature sintering of the pellets, facilitating charge transport among localized sites. Fig. 6(c and d) illustrates the Nyquist plots and fitted Nyquist plots of the sample at some selected temperatures, offering insights into the roles of grains and grain boundaries in its conduction mechanism. At lower frequencies, conduction is primarily governed by grain boundaries. In contrast, at higher temperatures, grains play a dominant role. The presence of semicircular arcs in the Nyquist plot further confirms the semiconducting nature of the sample. This equivalent circuit is composed of a suitable combination of resistance ( $R$ ) and capacitance ( $C$ ) connected in parallel for each arc. In addition, a constant phase element ( $Q$ ) is coupled with the RC circuit, providing information about the depression angle, *i.e.*, a departure from ideal Debye-type relaxation behavior. To provide a detailed view of the actual contribution of the grain and grain boundary, the Nyquist data were fitted and simulated with an equivalent electrical circuit, *i.e.*, (CQR)(CR) at some selected temperatures. In this study, the fitted parameters obtained from fitting the Nyquist data using the ZSIMPPWIN version 2.0 software code are bulk (grain) capacitance ( $C_g$ ), constant phase factor ( $Q$ ), bulk resistance ( $R_g$ ), grain boundary resistance ( $R_{gb}$ ), capacitance ( $C_{gb}$ ) and frequency power ( $n$ ), and these are listed in Table 1. It is observed that the grain boundary effect is suppressed and grain boundary resistance becomes effective at higher temperatures. The resistance at the grain boundary decreases from  $8.943 \times 10^9 \Omega \text{ cm}^2$  at  $25^\circ\text{C}$  to  $3.547 \times 10^5 \Omega \text{ cm}^2$  at  $500^\circ\text{C}$ . This confirms the NTCR character of the studied sample.<sup>69</sup>


**Table 1** Fitting parameters for BiFeO<sub>6</sub> from Nyquist plots after coupling with the equivalent circuit (CQR)(CR) using ZSIMPWIN version 20

Temperature	$C_g$ (F cm <sup>-2</sup> )	$Q$ (S <sup>2</sup> cm <sup>-2</sup> )	$R_g$ ( $\Omega$ cm <sup>2</sup> )	Frequency exponent ( $n$ )	$R_{gb}$ ( $\Omega$ cm <sup>2</sup> )	$C_{gb}$ (F cm <sup>-2</sup> )
25 °C	$4.9 \times 10^{-10}$ (Expt.) 4.9 × 10 <sup>-10</sup> (Fitting)	$2.714 \times 10^{-10}$ (Expt.) 2.717 × 10 <sup>-6</sup> (Fitting)	$8.943 \times 10^9$ (Expt.) 1.878 × 10 <sup>16</sup> (Fitting)	21.06	2.388 × 10 <sup>7</sup> (Expt.) 2.387 × 10 <sup>7</sup> (Fitting)	$1.122 \times 10^{-10}$ (Expt.) 1.122 × 10 <sup>-10</sup> (Fitting)
50 °C	$6.205 \times 10^{-10}$ (Expt.) 6.205 × 10 <sup>-10</sup> (Fitting)	$0.002798$ (Expt.) $2.8 \times 10^{-5}$ (Fitting)	$1.427 \times 10^{10}$ (Expt.) $3.741 \times 10^{11}$ (Fitting)	39.46	$6.174 \times 10^7$ (Expt.) $6.172 \times 10^7$ (Fitting)	$1.089 \times 10^{-10}$ (Expt.) $1.089 \times 10^{-10}$ (Fitting)
100 °C	$6.411 \times 10^{-10}$ (Expt.) 6.412 × 10 <sup>-10</sup> (Fitting)	$5.22 \times 10^{-5}$ (Expt.) $5.221 \times 10^{-5}$ (Fitting)	$1.048 \times 10^{11}$ (Expt.) $7.163 \times 10^{11}$ (Fitting)	59.03	$6.739 \times 10^7$ (Expt.) $6.737 \times 10^7$ (Fitting)	$1.084 \times 10^{-10}$ (Expt.) $1.084 \times 10^{-10}$ (Fitting)
150 °C	$4.972 \times 10^{-10}$ (Expt.) 4.972 × 10 <sup>-10</sup> (Fitting)	$4.842 \times 10^{-8}$ (Expt.) $4.842 \times 10^{-6}$ (Fitting)	$1.527 \times 10^{11}$ (Expt.) $3.523 \times 10^{15}$ (Fitting)	30.48	$1.986 \times 10^7$ (Expt.) $1.986 \times 10^7$ (Fitting)	$1.11 \times 10^{-10}$ (Expt.) $1.11 \times 10^{-10}$ (Fitting)
200 °C	$2.975 \times 10^{-19}$ (Expt.) $2.975 \times 10^{-19}$ (Fitting)	$2.949 \times 10^{-10}$ (Expt.) $2.95 \times 10^{-10}$ (Fitting)	$6.017 \times 10^5$ (Expt.) $6.016 \times 10^5$ (Fitting)	1.356	$1.012 \times 10^5$ (Expt.) $1.012 \times 10^5$ (Fitting)	$4.621 \times 10^{-10}$ (Expt.) $4.621 \times 10^{-10}$ (Fitting)
250 °C	$7.706 \times 10^{-11}$ (Expt.) 7.706 × 10 <sup>-11</sup> (Fitting)	$1.843 \times 10^{-9}$ (Expt.) $1.843 \times 10^{-10}$ (Fitting)	$1.285 \times 10^5$ (Expt.) $1.285 \times 10^5$ (Fitting)	1.108	$236.7$ (Expt.) $236.8$ (Fitting)	$1.633 \times 10^{-9}$ (Expt.) $1.633 \times 10^{-9}$ (Fitting)
300 °C	$7.226 \times 10^{-11}$ (Expt.) $7.24 \times 10^{-11}$ (Fitting)	$4.043 \times 10^{-10}$ (Expt.) $4.051 \times 10^{-10}$ (Fitting)	$9.554 \times 10^4$ (Expt.) $9.554 \times 10^4$ (Fitting)	9.018	$107.1$ (Fitting)	$4.174 \times 10^{-9}$ (Expt.) $4.174 \times 10^{-9}$ (Fitting)
350 °C	$8.682 \times 10^{-11}$ (Expt.) $8.684 \times 10^{-11}$ (Fitting)	$7.508 \times 10^{-10}$ (Expt.) $7.515 \times 10^{-10}$ (Fitting)	$1.414 \times 10^5$ (Expt.) $1.414 \times 10^5$ (Fitting)	1.746	$107.1$ (Fitting)	$4.131 \times 10^{-9}$ (Expt.) $4.131 \times 10^{-9}$ (Fitting)
400 °C	$4.821 \times 10^{-14}$ (Expt.) $1.528 \times 10^{-16}$ (Fitting)	$2.835 \times 10^{-11}$ (Expt.) $2.835 \times 10^{-10}$ (Fitting)	$9.344 \times 10^5$ (Expt.) $9.344 \times 10^5$ (Fitting)	2.83	$1.413 \times 10^4$ (Expt.) $1.413 \times 10^4$ (Fitting)	$6.576 \times 10^{-10}$ (Expt.) $6.577 \times 10^{-10}$ (Fitting)
450 °C	$8.318 \times 10^{-19}$ (Expt.) $8.307 \times 10^{-19}$ (Fitting)	$2.573 \times 10^{-10}$ (Expt.) $2.576 \times 10^{-10}$ (Fitting)	$3.926 \times 10^5$ (Expt.) $3.921 \times 10^5$ (Fitting)	2.461	$2.799 \times 10^5$ (Expt.) $2.798 \times 10^5$ (Fitting)	$2.744 \times 10^{-10}$ (Expt.) $2.744 \times 10^{-10}$ (Fitting)
500 °C	$2.64 \times 10^{-18}$ (Expt.) $2.419 \times 10^{-18}$ (Fitting)	$1.088 \times 10^{-8}$ (Expt.) $1.088 \times 10^{-9}$ (Fitting)	$3.547 \times 10^5$ (Expt.) $3.547 \times 10^5$ (Fitting)	2.78	$2.292 \times 10^5$ (Expt.) $2.292 \times 10^5$ (Fitting)	$1.663 \times 10^{-10}$ (Expt.) $1.663 \times 10^{-10}$ (Fitting)

### 3.8. Modulus study

Different phenomena, *e.g.*, bulk properties, conduction effect, relaxation time, effect of grain boundaries, electrode polarization, and electric transport process, can be understood from the electric modulus spectroscopy. It also helps in separating spectral components having different capacitances but the same resistances. Mathematical tools that were useful in calculating the complex modulus ( $M^*$ ), real modulus ( $M'$ ) and complex modulus ( $M''$ ) are as follows:

$$M^* = M' + jM''$$

$$M' = B \frac{(\omega\tau)^2}{1 + (\omega\tau)^2}$$

and

$$M'' = B \frac{\omega\tau}{1 + (\omega\tau)^2}$$

where,  $j = (-1)^{1/2}$ ;  $\tau$  = relaxation time and  $\omega$  = angular frequency. The bulk and grain boundary effects, along with the inhomogeneous nature of the polycrystalline sample, can be analyzed using the equations, which could not be fully explored through impedance spectroscopy. Additionally, modulation formulations play a crucial role in suppressing electrode effects, ensuring a more accurate characterization of the sample's electrical properties.<sup>70</sup> Fig. 7(a) represents the frequency *versus* real modulus ( $M'$ ) graph in a frequency range of 1 kHz–1 MHz at some selected temperatures. The 25 °C–150 °C plots show that at the low-frequency regions, the  $M'$  values are at their peak values compared to the rest of the temperature plots. The plots for 250 °C–350 °C have modulus values that are nearly equal to zero in the low-frequency regions. In the low-frequency regions, the modulus value dropping to zero may be due to the absence of electrode polarization or a low value. The merging of the plots and the attainment of high  $M'$  values in higher frequency regions can be attributed to low-mobility charge carriers, coupled with the absence of a restoring force under the induced electric field.<sup>70</sup> The  $M''$  value as a function of frequency for the selected temperatures is plotted in Fig. 7(b). The  $M''$  values increase with the increase in frequencies and reach a maximum value of  $M''_{\max}$ . The peaks for  $M''_{\max}$  shift towards a higher frequency region, depicting the presence of a relaxation phenomenon occurring in the sample.<sup>71</sup> The capacitance is inversely proportional to the height of the peak. The plots illustrate the transition from long-range to short-range charge carrier mobility. The region to the left of the peaks corresponds to long-range mobile charge carriers. Meanwhile, beyond  $M''_{\max}$ , the ions become confined within potential wells due to the short-range mobility of the charge carriers. A study of  $M''$  confirms the occurrence of non-Debye relaxation behaviour concluded from the appearance of asymmetrically broadened peak curves, unlike in an ideal Debye type.

The appearance of arcs at a frequency in the Cole–Cole plots shown in Fig. 7(c) signifies that the sample material has a single phase. The change in the nature of the curves with a temperature change is due to a change in the capacitances,

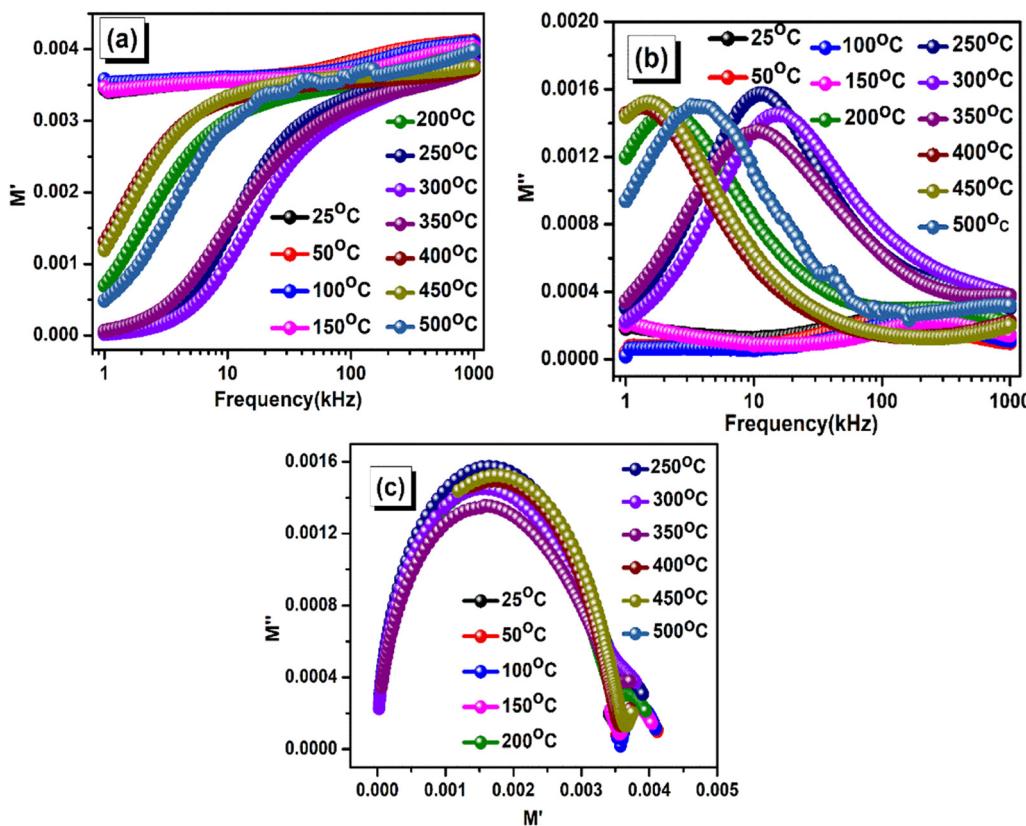


Fig. 7 (a)  $M'$  versus frequency, (b)  $M''$  versus frequency, and (c) Cole–Cole plots of  $\text{BiFeWO}_6$ .

which tells us about the temperature dependence of the capacitance. Some curves in the Cole–Cole plots have their centres lying below the real modulus axis, again providing evidence of the presence of a non-Debye-type relaxation process in the material. The intercept of large curves on the real modulus axis gives the value of the capacitance contribution from grains, whereas the intercepts of the smaller curves give the grain boundary capacitance contribution. These semicircular arcs are also an indication of the semiconducting nature of the sample.<sup>72</sup>

### 3.9. AC conductivity study

The ac conductivity of a sample can be calculated from dielectric data using the relation:  $\sigma_{\text{ac}} = \omega \epsilon_r \epsilon_0 \tan \delta$ , where  $\omega$  is the angular frequency,  $\epsilon_0$  is the permittivity of free space (approximately  $8.854 \times 10^{-12} \text{ F m}^{-1}$ ),  $\epsilon_r$  is the relative permittivity (or dielectric constant), and  $\tan \delta$  is the dielectric loss.<sup>73</sup> At low frequencies, the frequency-dependent conductivity plot stabilizes, forming a plateau that signifies DC conductivity, resulting from the random dispersion of ionic charge carriers through active hopping. On the other hand, in the high-frequency region, the plot becomes dispersive due to an increase in the conductivity. This increase in conductivity at high frequencies is indicative of the dynamic nature of charge transfer processes in the material. In essence, these studies allow us to understand the complex interplay between charge carriers, their transfer processes, and how these factors influence the overall

conductivity of the material. The frequency dependence of the conductivity of a sample can indeed be studied using Jonscher's universal power law, which is given by the equation:  $\sigma_{\text{ac}} = \sigma_{\text{dc}} + A\omega^n$ , where  $\sigma_{\text{ac}}$  is the ac conductivity,  $\sigma_{\text{dc}}$  is the dc conductivity,  $A$  is the polarizability strength,  $\omega$  is the angular frequency, and  $n$  is the frequency exponent which ranges from 0 to 2.<sup>74</sup>

The fitting data are recorded in Table 2. This law is widely used in the study of dielectric materials, and provides valuable insights into the behaviour of charge carriers in the material. The parameters  $A$  and  $n$  are typically determined through experimental measurements, and can provide information about the material's response to different frequencies.

Table 2 Evaluated values of the  $\sigma_{\text{dc}}$ ,  $n$ ,  $A$ , and  $R^2$  of  $\text{BiFeWO}_6$

Temperature (°C)	$\sigma_{\text{dc}}$ ( $\text{S m}^{-1}$ )	$n$	$A$	$R^2$
25	$-1.0715 \times 10^{-5}$	0.7778	$1.10156 \times 10^{-8}$	0.84933
50	$-1.3135 \times 10^{-5}$	0.77356	$1.16045 \times 10^{-8}$	0.80118
100	$-1.8911 \times 10^{-5}$	0.77889	$1.27098 \times 10^{-8}$	0.82463
150	$-1.1215 \times 10^{-5}$	0.76152	$1.50523 \times 10^{-8}$	0.98018
200	$2.6256 \times 10^{-5}$	0.80084	$1.21889 \times 10^{-8}$	0.99083
250	$1.6592 \times 10^{-4}$	0.81095	$1.35699 \times 10^{-8}$	0.99628
300	$2.3386 \times 10^{-4}$	0.81115	$1.65958 \times 10^{-8}$	0.99929
350	$1.6835 \times 10^{-4}$	0.97778	$1.77533 \times 10^{-9}$	0.99788
400	$2.6881 \times 10^{-5}$	1.42847	$2.2962 \times 10^{-12}$	0.9996
450	$3.0873 \times 10^{-5}$	1.46646	$1.1702 \times 10^{-12}$	0.9988
500	$4.9793 \times 10^{-5}$	1.11066	$2.3723 \times 10^{-10}$	0.9979



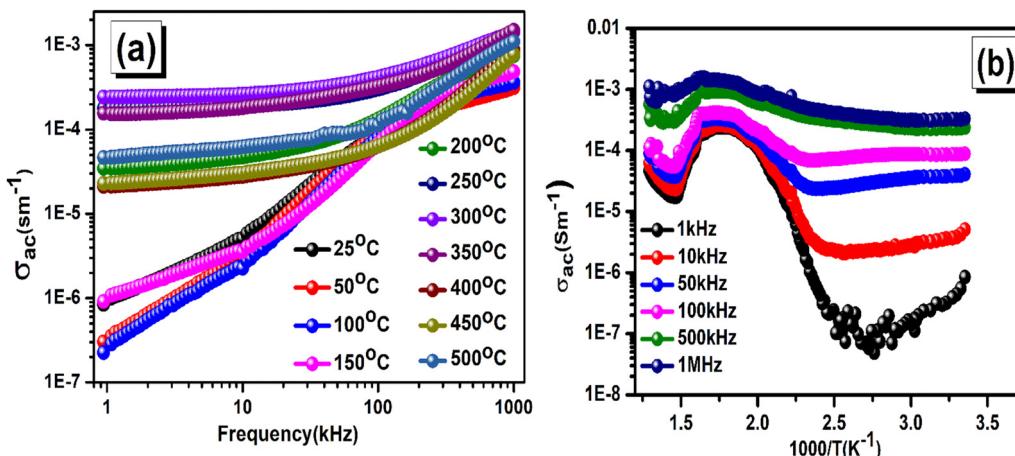


Fig. 8 (a)  $\sigma_{ac}$  versus frequency and (b)  $\sigma_{ac}$  versus  $1000/T$  plots of BiFeWO<sub>6</sub>.

Fig. 8(a and b) illustrates the variation of the AC conductivity as a function of frequency and  $10^3/T$  ( $K^{-1}$ ) at some selected frequencies. As shown in Fig. 8(a), the AC conductivity increases with both frequency and temperature, where the lower portion of the conductivity plot contributes to the DC conductivity. Examining the temperature dependence of the AC conductivity provides insights into the total real charge carriers within the sample. The rise in AC conductivity with increasing temperature confirms the NTCR characteristic, indicating semiconducting behavior. The activation energy of the ceramic compound can be determined using the Arrhenius equation:

$\sigma = \sigma_0 \times e^{\frac{-E_a}{k_B T}}$ , where  $k_B$  represents the Boltzmann constant and  $E_a$  denotes the activation energy.<sup>74</sup> The computed activation energy values at different frequencies are presented in Table 3. The observed decrease in activation energy with increasing frequency supports the presence of a thermally activated relaxation mechanism in the sample.

### 3.10. Thermistor characteristics

In previous sections, we explored the dielectric, optical, conducting, and transport properties of the ceramic sample. The impedance characteristics show the presence of both grain and grain boundary effects, as well as its NTCR behaviour. With the interest of exploring the industrial application, the authors then studied the thermistor characteristics of the ceramic sample. There are two types of thermistors: positive temperature coefficient (PTC) and negative temperature coefficient NTC. In PTC thermistors, the resistance increases with the rise

Table 3 Evaluated values of the activation energy and corresponding frequency of BiFeWO<sub>6</sub>

SI No.	Frequency	Activation energy ( $E_a$ ) (meV)
1	1 kHz	374.81
2	10 kHz	291.69
3	50 kHz	188.28
4	100 kHz	135.63
5	500 kHz	66.47
6	1 MHz	49.17

in temperature. Meanwhile, in NTC thermistors, the resistance decreases with the rise in temperature. Fig. 9(a) illustrates the variation of the resistance with temperature. The decrease in resistance with increasing temperature confirms the presence of the NTC thermistor nature up to 375 °C, PTC thermistor up to 425 °C, and then the NTC thermistor again up to 500 °C. Consequently, the BiFeWO<sub>6</sub> ceramic emerges as a promising candidate of a non-toxic thermistor suitable for various industrial applications.

#### (a) Activation energy

Fig. 9(b) illustrates the variations in the temperature-dependent activation energy ( $E_a$ ). The activation energy is determined using the mathematical relation presented as:  $E_a = k_B \times \beta$ , where  $k_B$  denotes the Boltzmann constant and  $\beta$  represents the thermistor constant. The activation energy curve exhibits a similar trend when compared to the behavior of the thermistor constant.

#### (b) Thermistor constant ( $\beta$ )

Fig. 9(c) shows the variation of the thermistor constant with temperature. The thermistor constant can be calculated using the empirical relation:  $\beta = \ln\left(\frac{R_1}{R_2}\right) / \ln\left(\frac{1}{T_1} - \frac{1}{T_2}\right)$ , where  $R_1$  and  $R_2$  are the initial and final resistances at temperatures  $T_1$  and  $T_2$ , respectively. The value of the thermistor constant falls in the good range for NTC thermistor applications.<sup>75</sup>

#### (c) Sensitivity factor ( $\alpha$ )

Fig. 9(d) shows the variation of the sensitivity factor versus temperature. The sensitivity factor represents a crucial parameter of thermistors, quantifying the rate at which resistance varies in response to temperature fluctuations. The sensitivity factor is calculated using the following mathematical relation:  $\alpha = \left(\frac{-\beta}{T^2}\right) \times 100$ , where  $\alpha$  is the sensitivity factor,  $\beta$  is the thermistor constant and  $T$  is the temperature in K.<sup>75</sup>

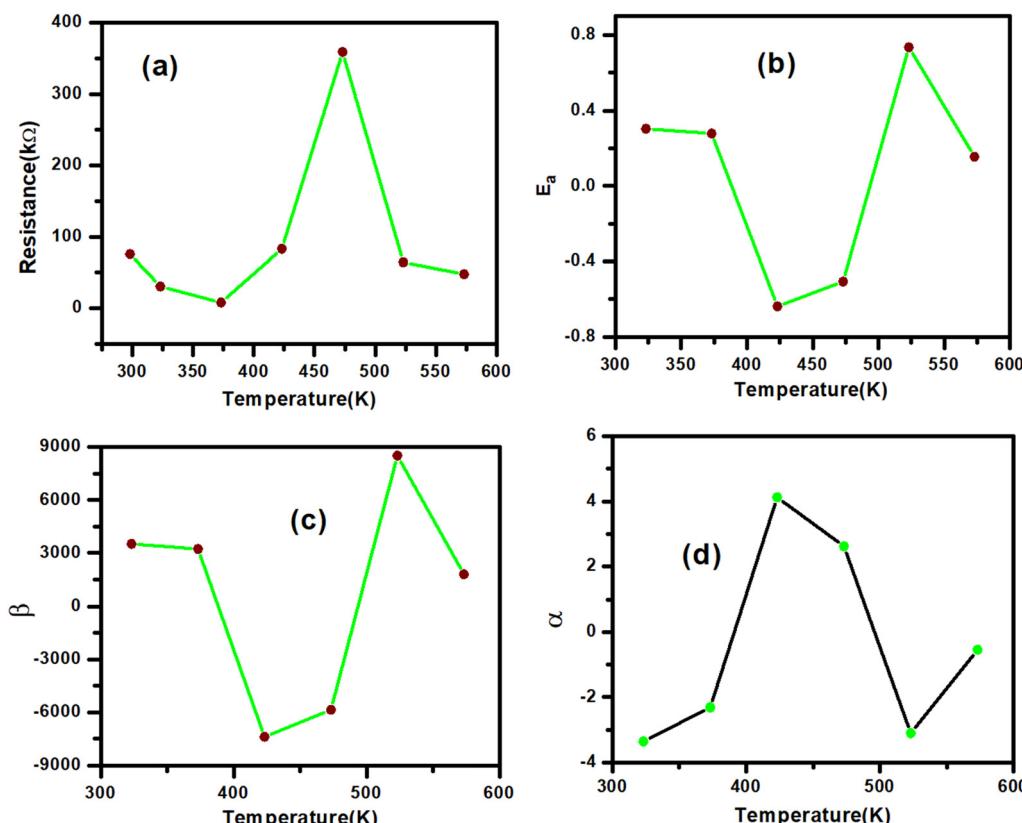


Fig. 9 (a) Variation in resistance with temperature, (b) activation energy versus temperature, (c) thermistor constant versus temperature and (d) sensitivity factor versus temperature of  $\text{BiFeWO}_6$ .

The mathematical relationship reveals that the parameter  $\alpha$  exhibits direct proportionality to  $\beta$ , while demonstrating an inverse dependence on the square of the temperature. A higher  $\alpha$  value corresponds to increased mobility of charge carriers compared to lower  $\alpha$  magnitudes. The figure illustrates the variation of the sensitivity factor with temperature, highlighting its nonlinear inverse correlation with the square of the absolute temperature. The presence of half-filled transition metal cations at the B-site, forming an octahedral coordination with oxygen, plays a pivotal role in enhancing the material properties. This structural configuration significantly contributes to improved findings, thereby broadening the scope of thermistor-related applications.<sup>76</sup>

### 3.11. Ferroelectric properties

The  $P$ - $E$  loop (Polarization–Electric field) is a graphical representation of the hysteresis behaviour of ferroelectric materials. It plots the polarization ( $P$ ) against the electric field ( $E$ ) applied to a material, demonstrating how the material retains its polarization even after the external field is removed.  $P$ - $E$  loops are widely used in research and applications such as ferroelectric memory devices, capacitors, and sensors. Since we are working with ferroelectric materials, analyzing the  $P$ - $E$  loop can provide valuable insights into their electrical properties. Lead-free relaxor ferroelectrics exhibit advantageous properties, including low remanent polarization, high maximum polarization, enhanced breakdown

strength, and excellent thermal stability. Extensive research has been conducted on dielectric energy storage materials utilizing relaxor ferroelectrics, particularly those based on  $\text{SrTiO}_3$  (ST),  $\text{BaTiO}_3$  (BT),  $\text{NaNbO}_3$  (NN), and  $\text{Na}_{0.5}\text{Bi}_{0.5}\text{TiO}_3$  (NBT) ceramics.<sup>77</sup>

Fig. 10 shows the  $P$ - $E$  loops at three different temperatures of 25 °C, 50 °C, and 100 °C. The plot shows the maximum polarization values of  $0.024 \mu\text{C cm}^{-2}$  at 25 °C, which gradually decreases to  $0.013 \mu\text{C cm}^{-2}$  at 50 °C and  $0.005 \mu\text{C cm}^{-2}$  at 100 °C. Also, it can be observed that with an increase in temperature values, the values of the remnant polarization and coercive field decrease.

The decrease in the coercive field value with increasing temperature while maintaining constant frequency signifies a reduction in the material's ability to retain polarization under an applied electric field. This phenomenon is primarily attributed to the thermal activation of dipoles, which disrupts their alignment and facilitates easier polarization switching. Additionally, as the material approaches its Curie temperature, its ferroelectric properties weaken, leading to a significant drop in the coercive field. Reduced domain wall pinning at elevated temperatures further contributes to this effect, as defects and lattice distortions that typically hinder domain movement become less restrictive. Moreover, structural softening at higher temperatures lowers the energy barrier required for domain switching, making polarization reversal more efficient. These temperature-dependent variations in the coercive field are



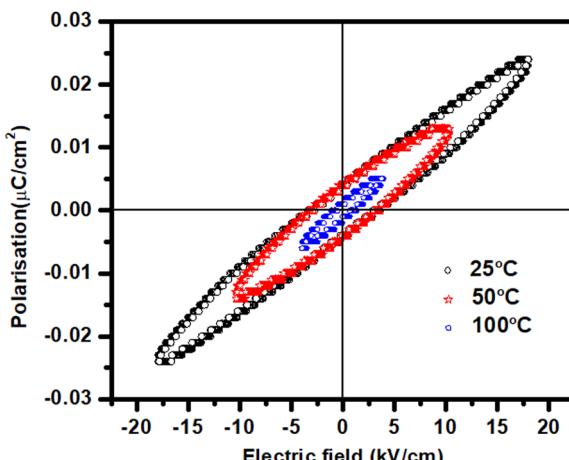


Fig. 10 *P-E* hysteresis loop of  $\text{BiFeWO}_6$ .

crucial for applications such as ferroelectric memory devices, capacitors, and sensors, where thermal stability plays a vital role in performance optimization.<sup>78,79</sup> An increase in temperature while keeping the frequency constant typically leads to a decrease in the remnant polarization. This occurs because the thermal energy disrupts the alignment of dipoles within the ferroelectric material, reducing its ability to retain polarization after the external electric field is removed. Additionally, as the temperature rises, the material may approach its Curie temperature, beyond which it loses its ferroelectric properties and transitions into a paraelectric phase. This phenomenon is crucial in applications such as pyroelectric sensors and ferroelectric memory devices, where temperature stability is essential.<sup>80</sup>

## 4. Conclusion

A  $\text{BiFeWO}_6$  ceramic was prepared using a solid-state reaction method and crystallizes in a tetragonal structure. The sample has high density and purity, which is confirmed from SEM and EDX analysis. Raman spectrum analysis confirms the vibrational modes of all constituent elements in the  $\text{BiFeWO}_6$  ceramic and supports the purity results from EDX analysis. The Raman study confirms the presence of all atomic vibrations. Meanwhile, the UV visible study reveals that the material has a bandgap energy of 1.41 eV, suitable for photovoltaic application. The dielectric study reveals the presence of the Maxwell-Wanger type of polarization effect, and possesses a high dielectric constant and low dielectric loss. The study of the impedance plots *versus* frequency at some selected temperatures confirms the NTCR nature, which is well-supported from the results of Nyquist plots. Analysis of the AC conductivity *versus* frequency & temperature reveals the fact that the conduction mechanism in the sample is controlled by the thermally activated charge carriers. Again, the calculated values of the activation energy from the conductivity study supports the semiconducting nature. The modulus plots reveal the presence of a non-Debye type of relaxation mechanism in the studied

sample. Meanwhile, the resistance *versus* temperature plots reveal both NTC and PTC thermistor characteristics. Finally, the P-E loop reveals the ferroelectric nature of the studied sample, emerging as a promising non-toxic thermistor for ferroelectric applications.

## Conflicts of interest

The authors declare that there is no conflict of interest.

## Data availability

Data will be made available from the authors upon reasonable request.

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